## Acta Crystallographica Section E

## Structure Reports

Online
ISSN 1600-5368

## 1,2-Bis[bis(methylsulfanyl)methylene]hydrazine

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Received 8 May 2008; accepted 14 May 2008

Key indicators: single-crystal X-ray study; $T=298 \mathrm{~K}$; mean $\sigma(\mathrm{S}-\mathrm{C})=0.003 \AA$; $R$ factor $=0.032 ; w R$ factor $=0.088 ;$ data-to-parameter ratio $=23.9$.

The title compound, $\mathrm{C}_{6} \mathrm{H}_{12} \mathrm{~N}_{2} \mathrm{~S}_{4}$, was obtained as a by-product ( $8 \%$ ) during the reaction of the electrogenerated cyanomethyl anion with phenylamine, carbon disulfide and methyl iodide. The molecule, with the exception of 8 H atoms, lies on a crystallographic mirror plane and is arranged around an inversion centre located at the mid-point of the $\mathrm{N}-\mathrm{N}$ bond.

## Related literature

For related literature, see: Pomes Hernandez et al. (1996); Toumi et al. (2007).


## Experimental

Crystal data
$\mathrm{C}_{6} \mathrm{H}_{12} \mathrm{~N}_{2} \mathrm{~S}_{4}$
$M_{r}=240.42$
Monoclinic, $\mathrm{C} 2 / \mathrm{m}$
$a=10.683$ (2) A
$b=7.193$ (1) $\AA$
$c=8.309$ (2) $\AA$
$\beta=117.66$ (2) ${ }^{\circ}$

## Data collection

$\begin{array}{ll}\text { Enraf-Nonius CAD-4 EXPRESS } & 885 \text { independent reflections } \\ \text { diffractometer } & 701 \text { reflections with } I>2 \sigma(I)\end{array}$
diffractometer
Absorption correction: $\psi$ scan
(North et al., 1968)
$T_{\text {min }}=0.79, T_{\text {max }}=0.84$
1994 measured reflections

## Refinement

$R\left[F^{2}>2 \sigma\left(F^{2}\right)\right]=0.032 \quad 37$ parameters
$w R\left(F^{2}\right)=0.088$
$S=1.06$
885 reflections
$V=565.5(2) \AA^{3}$
$Z=2$
Mo $K \alpha$ radiation
$\mu=0.79 \mathrm{~mm}^{-1}$
$T=298$ (2) K
$0.50 \times 0.29 \times 0.22 \mathrm{~mm}$

701 reflections with $I>2 \sigma(I)$
$R_{\text {int }}=0.027$
2 standard reflections
frequency: 120 min
intensity decay: $2 \%$

Data collection: CAD-4 EXPRESS (Duisenberg, 1992; Macíček \& Yordanov, 1992); cell refinement: CAD-4 EXPRESS; data reduction: XCAD4 (Harms \& Wocadlo, 1995); program(s) used to solve structure: SHELXS97 (Sheldrick, 2008); program(s) used to refine structure: SHELXL97 (Sheldrick, 2008); molecular graphics: ORTEPIII (Burnett \& Johnson, 1996) and ORTEP-3 for Windows (Farrugia, 1997); software used to prepare material for publication: WinGX (Farrugia, 1999).

Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: DN2348).

## References

Burnett, M. N. \& Johnson, C. K. (1996). ORTEPIII. Report ORNL-6895. Oak Ridge National Laboratory, Oak Ridge, Tennessee, USA.
Duisenberg, A. J. M. (1992). J. Appl. Cryst. 25, 92-96.
Farrugia, L. J. (1997). J. Appl. Cryst. 30, 565.
Farrugia, L. J. (1999). J. Appl. Cryst. 32, 837-838.
Harms, K. \& Wocadlo, S. (1995). XCAD4. University of Marburg, Germany.
Macíček, J. \& Yordanov, A. (1992). J. Appl. Cryst. 25, 73-80.
North, A. C. T., Phillips, D. C. \& Mathews, F. S. (1968). Acta Cryst. A24, 351359.

Pomes Hernandez, R., Gómez González, A., Rosado Pérez, A., Nápoles Frías, B. M., Toscano, R. A. \& Quincoces Suárez, J. (1996). Acta Cryst. C52, 29412942.

Sheldrick, G. M. (2008). Acta Cryst. A64, 112-122.
Toumi, M., Ben Amor, F., Raouafi, N., Bordeau, M., Driss, A. \& Boujlel, K. (2007). Acta Cryst. E63, o2735.

## supplementary materials

## 1,2-Bis[bis(methylsulfanyl)methylene]hydrazine

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## Comment

The structure is built up of $\mathrm{C}_{6} \mathrm{H}_{12} \mathrm{~N}_{2} \mathrm{~S}_{4}$ molecules which lie on mirror planes perpendicular to [010] direction. The molecule is centrosymetric around $\mathrm{N} 1-\mathrm{N} 1^{\mathrm{i}}$ bond (i: $1-x, 1-y, 1-z$ ) (figure 1).

The asymetric unit is built up by a nitrogen atom N 1 bonded to C 1 carbon which is bonded to sulfur atoms S 1 and S 2 , each of them is bonded to a carbon atom. The values of the bond distance $\mathrm{C} 1=\mathrm{N} 1(1.283 \AA)$, the bond distance average $\mathrm{C}-\mathrm{S}$ (1.782 (3) $\AA$ ), the angle S1C1S2 $\left(117.6(1)^{\circ}\right)$ and the angles average CSC (103 (1) $\left.)^{\circ}\right)$ agree with those found in compounds having such bonds (Pomes Hernandez et al., 1996; Toumi et al., 2007). The deviations of H1 and H3 atoms from the plane of the molecule are 0.79 (2) $\AA$ and 0.71 (2) $\AA$ respectively.

## Experimental

The title compound was obtained from the electrolysis of a mixture of acetonitrile (ACN) (70 ml) and hexamethylphosphorotriamide (HMPT) ( 6 ml ), under galvanostatic conditions ( $\mathrm{I}=105 \mathrm{~mA}, \mathrm{Q}=1,2 \mathrm{~F} / \mathrm{mol}$ ), in the presence of tetraethylammonium hexafluorophosphate (TEAPF6) ( 350 mg ) as supporting electrolyte. At the end of the electrolysis, the hydrazone (diarylhydrazone) was added and the solution was kept under continuous stirring for one hour, the carbon disulfide was added ( 20 mmol ) after 15 minutes of stirring and finally the methyl iodide was introduced and the solution was kept under stirring over night. After the removal of acetonitrile under reduced pressure, the residue was quenched with water and extracted with diethyl ether. The resulting product was chromatographed on silica gel (mesh 60, ethyl acetate / cyclohexane $1 / 9$ ) to afford a pure product (yield 8\%). Crystals suitable for X-ray analysis were grown by slow evaporation of dichloromethane solution.

The title compound was characterized by ${ }^{1} \mathrm{H},{ }^{13} \mathrm{C}$ NMR and MS spectra analysis. ${ }^{1} \mathrm{H}$ NMR $\left(\mathrm{CDCl}_{3}, 300 \mathrm{MHz}\right): 2.45$ (s, $\left.6 \mathrm{H}, \mathrm{CH}_{3}\right)$ and $2.52\left(\mathrm{~s}, 6 \mathrm{H}, \mathrm{CH}_{3}\right) .{ }^{13} \mathrm{C} \mathrm{NMR}\left(\mathrm{CDCl}_{3}, 75 \mathrm{MHz}\right): 13.8\left(\mathrm{CH}_{3}\right) ; 15.3\left(\mathrm{CH}_{3}\right)$ and $163.5(\mathrm{C}=\mathrm{N}) . \mathrm{MS}(\mathrm{EI})(\%)$ : $\mathrm{m} / z=240(35 / M+.) ; 193(20) ;(m-\mathrm{MeS}) ; 120(100) ;(M-(\mathrm{MeS}) 2 \mathrm{C}=\mathrm{N})$.

## Refinement

All H atoms attached to C atoms were fixed geometrically and treated as riding with $\mathrm{C}-\mathrm{H}=0.96 \AA$ (methyl) with $\mathrm{U}_{\text {iso }}(\mathrm{H})$ $=1.5 \mathrm{U}_{\mathrm{eq}}(\mathrm{C})$.

## supplementary materials

Figures


Fig. 1. Molecular view of the title compound with the atom-labelling scheme. Thermal ellipsoids are drawn at the $50 \%$ probability level. H atoms are represented as small spheres of arbitrary radii. [Symmetry code: (i) 1-x, 1-y, 1-z]

## 1,2-Bis[bis(methylsulfanyl)methylene]hydrazine

Crystal data
$\mathrm{C}_{6} \mathrm{H}_{12} \mathrm{~N}_{2} \mathrm{~S}_{4}$
$M_{r}=240.42$
Monoclinic, $C 2 / m$
Hall symbol: -C 2 y
$a=10.683$ (2) $\AA$
$b=7.193$ (1) $\AA$
$c=8.309(2) \AA$
$\beta=117.66$ (2) ${ }^{\circ}$
$V=565.5(2) \AA^{3}$
$Z=2$
$F_{000}=252$
$D_{\mathrm{x}}=1.412 \mathrm{Mg} \mathrm{m}^{-3}$
Mo K $\alpha$ radiation
$\lambda=0.71073 \AA$
Cell parameters from 25 reflections
$\theta=10-15^{\circ}$
$\mu=0.79 \mathrm{~mm}^{-1}$
$T=298$ (2) K
Plate, yellow
$0.50 \times 0.29 \times 0.22 \mathrm{~mm}$

## Data collection

## Enraf-Nonius CAD-4 EXPRESS

diffractometer
Radiation source: fine-focus sealed tube
Monochromator: graphite
$T=298(2) \mathrm{K}$
$\omega / 2 \theta$ scans
Absorption correction: $\psi$ scan
(North et al., 1968)
$T_{\text {min }}=0.79, T_{\text {max }}=0.84$
1994 measured reflections
885 independent reflections
701 reflections with $I>2 \sigma(I)$

## Refinement

Refinement on $F^{2}$
Least-squares matrix: full
$R\left[F^{2}>2 \sigma\left(F^{2}\right)\right]=0.032$
$w R\left(F^{2}\right)=0.088$

Secondary atom site location: difference Fourier map
Hydrogen site location: inferred from neighbouring sites
H -atom parameters constrained

$$
w=1 /\left[\sigma^{2}\left(F_{\mathrm{o}}^{2}\right)+(0.0422 P)^{2}+0.172 P\right]
$$

where $P=\left(F_{\mathrm{o}}^{2}+2 F_{\mathrm{c}}^{2}\right) / 3$
$S=1.06$
885 reflections
37 parameters
Primary atom site location: structure-invariant direct methods
$(\Delta / \sigma)_{\text {max }}=0.001$
$\Delta \rho_{\max }=0.26 \mathrm{e} \AA^{-3}$
$\Delta \rho_{\text {min }}=-0.22$ e $\AA^{-3}$
Extinction correction: none

## Special details

Geometry. All esds (except the esd in the dihedral angle between two 1.s. planes) are estimated using the full covariance matrix. The cell esds are taken into account individually in the estimation of esds in distances, angles and torsion angles; correlations between esds in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell esds is used for estimating esds involving 1.s. planes.
Refinement. Refinement of $F^{2}$ against ALL reflections. The weighted $R$-factor $w R$ and goodness of fit $S$ are based on $F^{2}$, conventional $R$-factors $R$ are based on $F$, with $F$ set to zero for negative $F^{2}$. The threshold expression of $F^{2}>\sigma\left(F^{2}\right)$ is used only for calculating $R$ factors(gt) etc. and is not relevant to the choice of reflections for refinement. $R$-factors based on $F^{2}$ are statistically about twice as large as those based on $F$, and $R$ - factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters ( $A^{2}$ )

|  | $x$ | $y$ | $z$ | $U_{\text {iso }} / U_{\text {eq }}$ |
| :--- | :--- | :--- | :--- | :--- |
| S1 | $0.83746(5)$ | 0.5000 | $0.78339(7)$ | $0.0648(2)$ |
| S2 | $0.58364(5)$ | 0.5000 | $0.85038(7)$ | $0.0605(2)$ |
| N1 | $0.57245(14)$ | 0.5000 | $0.5218(2)$ | $0.0493(4)$ |
| C1 | $0.65298(17)$ | 0.5000 | $0.6951(2)$ | $0.0435(4)$ |
| C2 | $0.7394(3)$ | 0.5000 | $1.0710(3)$ | $0.0695(7)$ |
| H2A | 0.7109 | 0.5000 | 1.1650 | $0.104^{*}$ |
| H2B | 0.7948 | 0.6090 | 1.0824 | $0.104^{*}$ |
| C3 | $0.8586(3)$ | 0.5000 | $0.5812(4)$ | $0.0732(8)$ |
| H3A | 0.9574 | 0.5000 | 0.6140 | $0.110^{*}$ |
| H3B | 0.8148 | 0.6090 | 0.5107 | $0.110^{*}$ |

Atomic displacement parameters $\left(A^{2}\right)$

|  | $U^{11}$ | $U^{22}$ | $U^{33}$ | $U^{12}$ | $U^{13}$ | $U^{23}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| S1 | $0.0283(2)$ | $0.1133(6)$ | $0.0464(3)$ | 0.000 | $0.01185(19)$ | 0.000 |
| S2 | $0.0414(3)$ | $0.0984(5)$ | $0.0439(3)$ | 0.000 | $0.0217(2)$ | 0.000 |
| N1 | $0.0286(6)$ | $0.0772(12)$ | $0.0392(7)$ | 0.000 | $0.0132(6)$ | 0.000 |
| C1 | $0.0302(7)$ | $0.0566(11)$ | $0.0413(8)$ | 0.000 | $0.0146(6)$ | 0.000 |
| C2 | $0.0619(13)$ | $0.1011(19)$ | $0.0380(9)$ | 0.000 | $0.0168(9)$ | 0.000 |
| C3 | $0.0475(11)$ | $0.116(2)$ | $0.0656(13)$ | 0.000 | $0.0339(10)$ | 0.000 |

## Geometric parameters ( $\AA,{ }^{\circ}$ )

| $\mathrm{S} 1-\mathrm{C} 1$ | $1.7550(18)$ | $\mathrm{N} 1-\mathrm{N} 1^{\mathrm{i}}$ | $1.417(3)$ |
| :--- | :--- | :--- | :--- |
| $\mathrm{S} 1-\mathrm{C} 3$ | $1.796(3)$ | $\mathrm{C} 2-\mathrm{H} 2 \mathrm{~A}$ | 0.9600 |
| $\mathrm{~S} 2-\mathrm{C} 1$ | $1.7609(19)$ | $\mathrm{C} 2-\mathrm{H} 2 \mathrm{~B}$ | 0.9600 |

## supplementary materials

| S2—C2 | $1.816(2)$ | $\mathrm{C} 3-\mathrm{H} 3 \mathrm{~A}$ | 0.9600 |
| :--- | :--- | :--- | :--- |
| $\mathrm{~N} 1-\mathrm{C} 1$ | $1.290(2)$ | $\mathrm{C} 3-\mathrm{H} 3 \mathrm{~B}$ | 0.9600 |
| $\mathrm{C} 1-\mathrm{S} 1-\mathrm{C} 3$ | $102.32(10)$ | $\mathrm{S} 2-\mathrm{C} 2-\mathrm{H} 2 \mathrm{~A}$ | 109.5 |
| $\mathrm{C} 1-\mathrm{S} 2-\mathrm{C} 2$ | $103.88(10)$ | $\mathrm{S} 2-\mathrm{C} 2-\mathrm{H} 2 \mathrm{~B}$ | 109.5 |
| $\mathrm{C} 1-\mathrm{N} 1-\mathrm{N} 1^{\mathrm{i}}$ | $111.67(18)$ | $\mathrm{H} 2 \mathrm{~A}-\mathrm{C} 2-\mathrm{H} 2 \mathrm{~B}$ | 109.5 |
| $\mathrm{~N} 1-\mathrm{C} 1-\mathrm{S} 1$ | $120.29(14)$ | $\mathrm{S} 1-\mathrm{C} 3-\mathrm{H} 3 \mathrm{~A}$ | 109.5 |
| $\mathrm{~N} 1-\mathrm{C} 1-\mathrm{S} 2$ | $121.90(13)$ | $\mathrm{S} 1-\mathrm{C} 3-\mathrm{H} 3 \mathrm{~B}$ | 109.5 |
| S1—C1—S2 | $117.81(10)$ | $\mathrm{H} 3 \mathrm{~A}-\mathrm{C} 3-\mathrm{H} 3 \mathrm{~B}$ | 109.5 |
| Symmetry codes: (i) $-x+1,-y+1,-z+1$ |  |  |  |

Fig. 1


